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1	Nucleation of Dislocations in 3.9 nm Nanocrystals at High Pressure
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18	Abstract:
19	As circuitry approaches single nanometer length scales, it has become important to predict the
20	stability of single nanometer-sized metals. The behavior of metals at larger scales can be predicted

- 21 based on the behavior of dislocations, but it is unclear if dislocations can form and be sustained at
- single nanometer dimensions. Here, we report the formation of dislocations within individual 3.9
- 23 nm Au nanocrystals under nonhydrostatic pressure in a diamond anvil cell. We used a combination

of x-ray diffraction, optical absorbance spectroscopy, and molecular dynamics simulation to characterize the defects that are formed, which were found to be surface-nucleated partial dislocations. These results indicate that dislocations are still active at single nanometer length scales and can lead to permanent plasticity.

28

#### 29 Main text:

30 Permanent plastic deformation occurs in bulk crystalline metals that are subjected to large strains 31 at room temperature. This irreversible deformation can be due to the short-range interactions 32 between dislocations, or the formation of dislocation arrays at grain or twin boundaries. Recently, 33 reversible deformation from large strains has been observed in sub-10 nm Ag nanocrystals [1] and 34 3.9 nm Au nanocrystals, [2] in which the nanocrystal rapidly recovers from a flattened state after 35 load is removed, and reverts to its original faceted shape. The mechanisms behind this behavior 36 remain unclear, as there is evidence for both diffusion and dislocation mediated plasticity. Rapid 37 diffusion of atoms at free surfaces and stress-induced diffusion at the nanocrystal-indenter and 38 nanocrystal-substrate interfaces have been proposed as mechanisms, based on theoretical 39 considerations and *in situ* transmission electron microscope (TEM) observations [1,3]. Others 40 have instead observed surface-nucleated dislocations and deformation twinning in sub-10 nm 41 nanowires, and stacking faults tetrahedra in sub-20 nm nanowires under tension in both 42 experiments and molecular dynamics (MD) simulations [4-7]. Dislocations and diffusion may 43 also act cooperatively. In situ TEM tension tests on ~20 nm and sub 5 nm Ag nanowires showed 44 that surface diffusion is enhanced at surface steps created by the passage of dislocations [8,9]. 45 Previous work from our group showed that pseudoelastic shape recovery (diffusion mediated 46 process) in 3.9 nm Au nanocrystals is accompanied by the formation of irreversible defects, but47 the nature of the defects could not be determined [2].

48 These observations prompt the questions: Is there a limit to plasticity at small length scales? 49 What is the smallest crystal in which dislocations can form and lead to irreversible deformation? 50 This is critical to the processing and mechanical behavior of nanostructured materials such as 51 nanocrystalline, nanotwinned and nanoporous metals, and the design of stable nano-devices with 52 single nanometer metallic features [10]. To answer these questions, deformation mechanisms in 53 very small nanocrystals must be experimentally determined, but this remains challenging. In situ 54 TEM mechanical testing is the leading method to investigate deformation mechanisms at this 55 length scale, but results may be influenced by heating from the electron beam. In addition, fast 56 dislocations and dislocations that are invisible at specific imaging conditions cannot be observed. 57 X-ray diffraction (XRD) is another method to measure elastic strain and defect formation in metals 58 under mechanical stress. The width and relative intensities of XRD peaks have previously been 59 used to detect dislocation activity in nanocrystalline Ni under uniaxial tension [11] and 60 compression in a diamond anvil cell (DAC) [12]. These studies involve the response at grain 61 boundaries as well as within the grains, so they cannot be directly applied to understand plasticity 62 in individual nanocrystals. To do this, the structural response of isolated nanocrystals must be 63 obtained. This presents a challenge for *in situ* XRD because the diffracted intensities from a single 64 nanocrystal are much too small for detection.

Here, we use XRD to detect structural changes in an ensemble of monodisperse 3.9 nm Au nanocrystals that are compressed under a non-hydrostatic pressure in a DAC. Surfaces of the nanocrystals are protected by organic ligands, which prevents contact between the nanocrystals. Structural changes from XRD are corroborated with optical spectroscopy measurements, and MD

69 simulations are used to determine the specific defects that correspond to the ensemble-averaged 70 behavior from XRD. We show that irreversible deformation due to the formation of surface 71 nucleated partial dislocations can occur in small metallic nanocrystals. This indicates that 72 dislocation-mediated plasticity is still active at single nanometer length scales and must be 73 considered in designing structures at this scale. Theoretical work on homogenous dislocation 74 nucleation has been studied well for nanoindentation experiments on larger nanocrystals [new 75 refs]. However, these results prompt for development of theoretical work on heterogenous 76 dislocation nucleation from nanocrystal surface in compression in DAC.

77 Au nanocrystals were synthesized using the organic phase reduction of chloroauric acid 78 and capped with dodecanethiol ligands [13]. The nanocrystal size distribution was found to be 79 3.9±0.6 nm using TEM (see Fig. 1A and see the Supplementary Material [14]). High-resolution 80 TEM images showed that most of the identified nanocrystals were either icosahedral or decahedral 81 in shape (Fig. 1B-C). Icosahedral nanocrystals have 20 twin boundaries, and decahedral 82 nanocrystals have 5 twin boundaries. Ambient pressure XRD showed an FCC crystal structure, 83 and significantly broader peaks than bulk Au due to the limited coherent scattering volume within 84 the nanocrystals (see the Supplementary Material [14]). The (111), (220), (311) and (222) XRD 85 peaks were shifted to higher  $2\theta$  angles by ~ $0.1^{\circ}$  compared to that of the bulk, which corresponds to a ~1.8% volumetric compressive strain. The position of the (200) peak was shifted to lower 2 $\theta$ 86 87 angles by 0.15°. Broad shoulders were observed on the (200) and (220) peaks. These features are 88 indicative of the high twin density in icosahedral and decahedral nanocrystals [22]. In addition, 89 the (111) peak showed asymmetric broadening due to tensile and compressive stresses at the 90 surfaces and the interior of the nanocrystals due to surface stresses [30]. The Au nanocrystals 91 consist of ~20% surface atoms with most of the surface covered with (111) planes. As a result, the

92 (111) peak shows the most asymmetrical broadening compared to the other peaks. The Debye 93 scattering equation was used to fit the XRD pattern to determine the structure of the nanocrystals. 94 In this method, the atomic positions for icosahedral and decahedral nanocrystals were generated 95 for 1 to 6 nm diameter nanocrystals and used to simulate XRD patterns. A Rietveld-like refinement 96 procedure was used to fit the experimental data [22,24]. The best fit was obtained by combining 97 60% icosahedral nanocrystals with a size distribution of 3.2±0.2 nm and 40% decahedral 98 nanocrystals with a size distribution of  $3.8\pm0.6$  nm (see the Supplementary Material [14]). This 99 result is in close agreement with the nanocrystal shape and size distribution observed in TEM.

100 High pressure XRD was obtained during DAC compression experiments at the Advanced 101 Light Source at Lawrence Berkeley National Laboratory (Fig. 2A-B). A non-hydrostatic pressure 102 was applied to the nanocrystals by loading the nanocrystals as a thick film at the bottom of the 103 DAC sample chamber, and using toluene as a non-hydrostatic pressure medium [31]. XRD was 104 collected while the nanocrystals were loaded up to 7.5 GPa and as pressure was released. The 105 pressure was limited to 7.5 GPa to avoid sintering between the nanocrystals, which has been 106 observed by our group and others at higher pressures [32–34]. The XRD peak position and width 107 (full width at half max) were observed to change with increasing and decreasing pressure and 108 quantified at each pressure (Fig. 2C-D). The relative intensity of the XRD peaks does not change 109 under pressure, which indicates that the nanocrystals remain randomly oriented.

The change in peak position indicates the elastic strain in the nanocrystals. The shift in the peak position shows that the lattice spacing decreases by 0.042 Å over 7.5 GPa and recovers to ~0.2% of its original value upon unloading. The (200) peak position gives information about the extent of twinning in the sample (see Fig. S8 for the qualitative effect of twinning on the XRD peak). The complete recovery of the (200) peak position indicates that the initial multiply twinned

115 structure (icosahedral/decahedral) is preserved after the pressure cycle. Due to the non-hydrostatic 116 pressure, the change in lattice spacing is different along the loading axis (axial) and orthogonal to 117 the loading axis (radial). The geometry of the X-ray setup is such that the measured lattice spacings 118 correspond to planes that are almost aligned with the loading axis. Therefore, the measured change 119 in lattice spacing is lower than in the hydrostatic case (see the Supplementary Material [14]). The 120 difference between radial and axial stress components (termed as t) can give us an estimate of 121 maximum deviatoric and shear stresses in the system. This difference can be calculated by 122 considering the elastic anisotropy of a polycrystalline, FCC metal. We used lattice strain theory to 123 get a rough estimate of 't' [29,35] (see the Supplementary Material [14]). Using this we estimated 124 the maximum shear stress of Au nanoparticles to be about 2.3 GPa (see the Supplementary 125 Material [14]).

126 Fig. 2D shows the change in peak width for the (111), (200) and (220) peaks with a 127 complete pressure cycle. The (200) peak width showed a significant increase of 16% and the (220) 128 peak width showed an increase of 23% with increasing pressure and remained at higher values 129 after unloading. This indicates that irreversible deformation is occurring in the nanocrystals and 130 remains in the nanocrystals on the time scale of the experimental measurements. The XRD peak 131 width can be affected by changes in crystallite size, shape and microstrain [36]. It is possible that 132 crystalline domains within the nanocrystal become elongated under compression and split into 133 smaller domains, but post-compression TEM images showed that the nanocrystal shape and size 134 distribution is identical to that of the as-synthesized nanocrystals (see the Supplementary 135 Material [14]). The (111) peak width is mostly affected by domain size changes and is least 136 affected by the presence of defects like twinning and stacking faults in the nanocrystal (see the 137 Supplementary Material [14]). The peak width for (111) peak remained at about 2% of its initial

value with pressure cycling. The insignificant change in the (111) peak width also indicates that domain size does not change under pressure [22,37]. From this analysis, we determine that the increased peak width after unloading is caused by the formation of crystalline defects such as dislocations rather than changes in the size and shape of crystalline domains. The observation that (200) and (220) peak were the most affected and the (111) peak is least affected indicates the presence of stacking faults, twinning and dislocations (see the Supplementary Material [14]).

144 These XRD results were corroborated by high-pressure optical absorbance spectroscopy. 145 Au nanocrystals have a plasmonic resonance that is dependent upon nanocrystal size, shape and 146 microstructure [38]. Previous optical modeling showed that the plasmon peak wavelength is 147 indicative of nanocrystal shape, while an irreversible decrease in the plasmon peak intensity is 148 indicative of the formation of crystalline defects [2]. The plasmon peak wavelength of the 3.9 nm 149 Au nanocrystals increased by ~30 nm when pressure was increased to 7.5 GPa and recovered its 150 initial value upon unloading (see the Supplementary Material [14]). These optical measurements 151 showed that the nanocrystals elongate into ellipsoids and then recover their original shape after 152 unloading. The plasmon peak intensity showed an irreversible decrease after unloading. The 153 reduced absorbance peak intensity after unloading is correlated to the formation of defects in 154 nanocrystals through a damping factor [2]. The optical data supports the conclusion that the 155 irreversible increase in XRD peak width after pressure cycling is due to the formation of crystalline 156 defects, rather than a change in the size and shape of crystalline domains within the nanocrystals. 157 UV-vis absorbance provides conclusive information about nanocrystal shape, and XRD provides 158 conclusive information about defect formation.

159 MD simulations were used to understand the crystalline defects that form within the 160 nanocrystals, and their interactions with existing twin boundaries and surfaces. Two types of

161 stacking faults (SF) were formed in an icosahedral nanocrystal under pressure (Fig. 3A); SF type 162 1 refers to a stacking fault parallel to the outer surface of the nanocrystal (or parallel to surface 163 steps formed during deformation), and SF type 2 is a stacking fault parallel to an internal twin 164 boundary that intersects with two other twin boundaries. Both types of stacking fault were formed 165 by the nucleation and propagation of a Shockley partial dislocation with a Burgers vector of  $\frac{1}{6}$  (112)*a*. SF type 1 forms when a Shockley partial dislocation with Burgers vector parallel to the 166 167 outer surface propagates on a slip plane parallel to the outer surface. This results in a displacement 168 relative to adjacent grains that is about the magnitude of the Burgers vector (see the Supplementary 169 Material [14]). When trailing partials are activated on the same plane, the stacking fault is 170 removed, which results in the formation of a larger displacement. The trailing partial slip in one 171 grain sometimes triggers stacking fault formation in an adjacent grain. This occurs if the Burgers 172 vector of the trailing partial dislocation (i.e. the slip direction) is aligned well with the Burgers 173 vector of a leading partial dislocation (Fig. 3B). SF type 2 is a dislocation that has a Burgers vector 174 parallel to an interior twin boundary. The passage of SF type 2 is blocked by intersecting twin boundaries and forms interfacial dislocations with a  $\frac{1}{9}\langle 222\rangle a$  Burgers vector. This type of stacking 175 176 fault has also been observed in penta-twinned silver nanowire with >40 nm diameter [39]. In 177 contrast to the penta-twinned silver nanowires, the trailing partial does not follow the leading 178 partial (or, the SF type 2) in the 3.9 nm nanocrystal because the image stress is very large due to 179 the proximity to the free surface and opposes the motion of the trailing partial. For this reason, SF 180 type 2 is harder to form, and the plastic deformation of the nanocrystal is dominated by the 181 successive formation of SF type 1 defects. This is in contrast with work by Sun et al. on Ag 182 nanocrystals where they reported liquid like deformation via surface diffusion; however, they had 183 performed very high temperature MD simulations to observe diffusion activity in MD time

scale [1]. We conducted room-temperature MD simulations where surface diffusion was limited.
This is in line with experiments where the Au nanocrystal surface was protected by bulky organic
ligands that form Au-SR bonds which prevent diffusion at the nanocrystal surface [40].

187 We attribute the irreversible deformation in the nanocrystals to SF type 1 defects, as 188 portions of these defects remain in the simulated nanocrystal after unloading (See Fig. 3B). The 189 stacking fault parallel to the outer surface is energetically meta-stable, because of the finite energy 190 barrier required to form a partial dislocation to reversely sweep out the stacking fault. In 191 experimental time scales, some meta-stable stacking faults can be expected to remain. In contrast, 192 SF type 2 escapes quickly to the free surface during unloading upon the removal of deviatoric 193 stress, which implies that the plastic deformation by this type of stacking fault is reversible. SF 194 type 2 forms a partial dislocation loop that is blocked by twin boundaries. This is an unstable 195 structure that is easily pulled towards the free surface by an image stress [39].

196 The correspondence between the experimental data and MD simulation was evaluated by 197 generating XRD patterns from the MD simulated structures at different pressures by using the 198 Debye scattering equation [24] (see Fig. 4A-B). The Debye scattering equation is a Fourier 199 transform of the interatomic distances in a nanocrystal. Large ripples are observed in the computed 200 patterns due to the small number of atoms in a finite sized nanocrystal (see Fig. S10). These ripples 201 become less prominent when diffraction patterns for different sized nanocrystals are combined. 202 Figure 4 shows the average XRD pattern for 3.5, 3.9, and 4.5 nm icosahedral and 4 nm decahedral 203 nanocrystals to mimic the experimental nanocrystal size distribution. A small ripple to the left of 204 (111), and to the right of (200) and (220) can still be observed in Figure 4. While these ripples 205 could be further smoothened by simulating the same nanocrystal size distribution as in 206 experiments, this is infeasible due to constraints on computing time. The XRD peaks were fitted

207 using Lorentzian and Gaussian peak profile with a high order polynomial for the background. Due 208 to the ripple on the (220) peak, the exact (220) peak width cannot be obtained but can still be 209 analyzed qualitatively. The XRD peak width for the simulated patterns showed a similar trend to 210 experimental data in that the (111) peak width broadened the least, and the (200) peak broadened 211 the most under pressure (Fig. 4C-D). The (220) peak width also increased, similarly to experiments 212 (Fig. S11). The effect of adding stacking faults to the nanocrystal is evident from the significant 213 increase of peak width for the (200) and (220) peaks. The close agreement of MD simulated XRD 214 patterns and experimental XRD patterns shows that MD simulations are a true representation of 215 experiments.

216 In summary, using high-pressure XRD, optical absorbance spectroscopy and MD 217 simulations we provide the first evidence of plastic deformation in individual 3.9 nm Au 218 nanocrystals. The plastic deformation governed was by stacking faults formed via surface 219 nucleated partial dislocations. The formation of surface steps during the passage of sequential 220 partial dislocations as well as remaining stacking faults led to residual defects in the nanocrystal. 221 The kinetics of residual defect recovery after unloading the sample will be explored further in 222 future studies. This work provides a critical advancement in using experimental and simulation 223 generated XRD as a comprehensive measurement technique to study defect formation in 224 nanomaterials.

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## 305 Figures



306

**Fig. 1. TEM images of nanocrystals.** A) Monodisperse 3.9 nm Au nanocrystals. Scale bar is 10

308 nm. High-resolution images of B) icosahedral and C) decahedral nanocrystals. Scale bar is 4 nm.



311 Fig. 2. Experimental high-pressure XRD patterns. A) All diffraction peaks and B) magnified

312 view of (111) and (200) peaks. Change in diffraction peak C) position and D) width (each

313 division is 0.1°), upon loading (solid line) and unloading (dashed line).



314

315 Fig. 3. MD simulation of a 3.9 nm icosahedral nanocrystal. A) Schematic of nanocrystal 316 geometry and slip planes for stacking fault type 1 and type 2. B) Atomic configurations during 317 loading and unloading process. Top row shows the surface atoms and the loading direction (red 318 arrows). In the next two rows, outermost atoms are omitted to visualize the formation of defects. 319 Images in middle row have green atoms for FCC, white atoms for unclassified crystal structure 320 (typically near the core of a partial dislocation or at the surface), and red atoms for HCP. Images 321 in bottom row are colored according to non-affine squared displacement, in which the slip plane 322 swept by a perfect dislocation is identified.



325 Fig. 4. Simulated high-pressure XRD patterns from MD simulations. A) All diffraction

326 peaks and B) magnified view of (111) and (200) peaks. Change in diffraction peak C) position

327 and D) width (each division is 0.1°), upon loading (solid line) and unloading (dashed line).

328